

VLSI Devices

Lecture 11

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Drain current

- Electron current density at a point (x, y)

$$J_n(x, y) = -q\mu_n n(x, y) \frac{dV}{dy} \quad \text{Taur, Eq. (3.5)}$$

$$\mathbf{J}_n = -q\mu_n n \nabla \phi_n$$

- (It includes both the drift and diffusion currents.)
- When integrated from $x = 0$ to x_i , (and from $z = 0$ to W)

$$I_d(y) = qW \int_0^{x_i} \mu_n n(x, y) \frac{dV}{dy} dx \quad \text{Taur, Eq. (3.6)}$$

Sign change due to
convention of
terminal current

z-directional
width

Further simplification

- Electron current density at a point (x, y)

$$\begin{aligned} I_d(y) &= qW \int_0^{x_i} \mu_n n(x, y) \frac{dV}{dy} dx = -\mu_{eff} W \frac{dV}{dy} \left(-q \int_0^{x_i} n(x, y) dx \right) \\ &= -\mu_{eff} W \frac{dV}{dy} Q_i(y) \end{aligned} \quad \text{Taur, Eq. (3.8)}$$

- We introduce an effective mobility, μ_{eff} .
- Since V is a function of y only, V is interchangeable with y .

$$Q_i(y) = Q_i(V)$$

- Then,

$$I_d(y) dy = \mu_{eff} W [-Q_i(V)] dV$$

$I_d(y)$ is actually a constant.

- When integrated from $y = 0$ to L , (from $V = 0$ to V_{ds})

$$I_d = \mu_{eff} \frac{W}{L} \int_0^{V_{ds}} [-Q_i(V)] dV \quad \text{Taur, Eq. (3.10)}$$

- Then, how can we find $Q_i(V)$? (We must perform the x -directional integration.)

$$Q_i = -q \int_0^{x_i} n(x, y) dx = -q \int_{\phi_s}^{\delta} n(\phi, V) \frac{dx}{d\phi} d\phi$$

It's small, but not zero.

$$= -q \int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V)\right)}{E_x(\phi, V)} d\phi \quad \text{Taur, Eq. (3.12)}$$

Pao-Sah double integral

- Finally, the expression for I_d reads


$$I_d = q\mu_{eff} \frac{W}{L} \int_0^{V_{ds}} \left[\int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V)\right)}{E_x(\phi, V)} d\phi \right] dV$$

Taur, Eq. (3.13)

- It is the Pao-Sah double integral.
- Rigorous within the GCA, but it is difficult to evaluate.

How can we determine ϕ_s ?

- For given V_{gs} and V , we can solve the MOS equation.

$$V_{gs} = V_{fb} + \phi_s - \frac{Q_s}{C_{ox}}$$
$$= V_{fb} + \phi_s + \frac{\sqrt{2\epsilon_{si}k_B T N_a}}{C_{ox}} \left[\frac{q\phi_s}{k_B T} + \frac{n_i^2}{N_a^2} \exp\left(\frac{q}{k_B T}(\phi_s - V)\right) \right]^{1/2}$$


Taur, Eq. (3.14)

Only two important
terms are kept.

- We can numerically solve the above equation to obtain ϕ_s . (Newton method)

Write a code. (1) ← These are optional.

- Calculate I_d at $V_{gs} = 1.1$ V and $V_{ds} = 0.5$ V.
 - We follow the Riemann sum approach.
 - Then, let's introduce 101 V values, from 0 V to 0.5 V. (5 mV spacing)

$$I_d \approx q\mu_{eff} \frac{W}{L} \sum_{j=0}^{100} \left[\int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V_j)\right)}{E_x(\phi, V_j)} d\phi \right] \Delta V_j$$

- When $j = 0$ or $j = 100$, ΔV_j is 2.5 mV.
- Otherwise, ΔV_j is 5 mV.
- Use $q\mu_{eff} \frac{W}{L} = 4.8 \times 10^{-17}$ A cm² V⁻¹. (A rough estimation for n_i , 10^{10} cm⁻³, is used.)

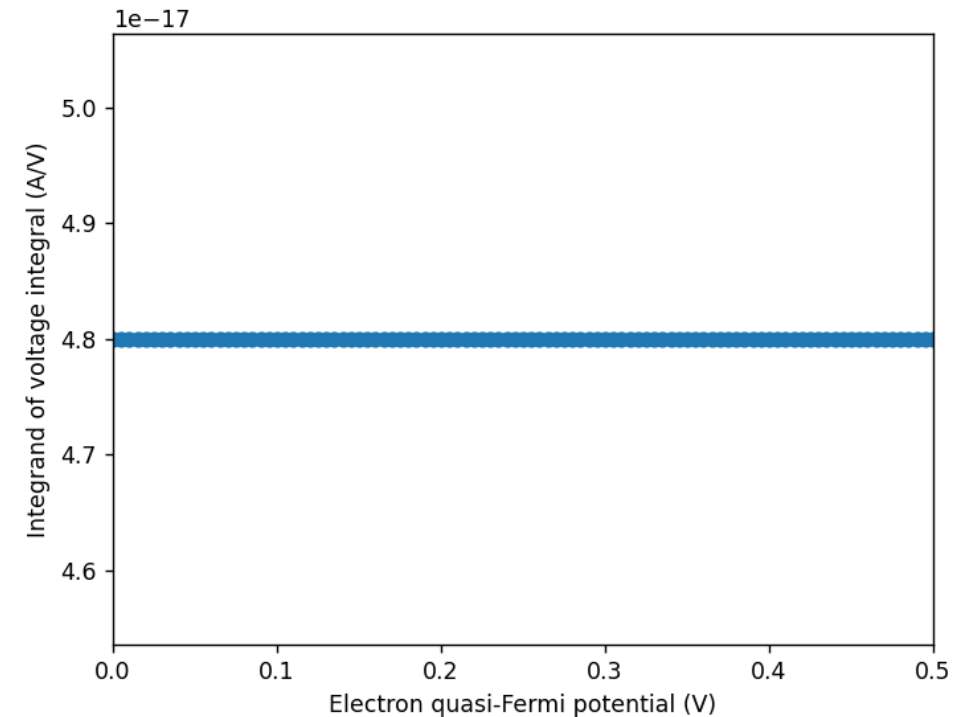
Write a code. (2)

- Test the integral.

– Assume that $\left[\int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T}(\phi - V_j)\right)}{E_x(\phi, V_j)} d\phi \right] = 1 \text{ cm}^{-2}.$

- Then, the integral should be $2.4 \times 10^{-17} \text{ A}.$
- Check your code.

2.399999999999999955e-17



Write a code. (3)

- Now, we must perform the ϕ -integral.

$$\int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V_j)\right)}{E_x(\phi, V_j)} d\phi$$

- We must know two bounds, δ and ϕ_s .
- We can set a small value for δ . (It doesn't matter. $\delta = V_j + 1$ mV, for example)
- However, ϕ_s is not easy to evaluate. (We must adopt the Newton method.)
- Instead, an approximate value for ϕ_s will be used.

Write a code. (4)

- The ϕ -integral is approximated as

$$\int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V_j)\right)}{E_x(\phi, V_j)} d\phi$$
$$\approx \sum_{k=1}^{k_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (k \text{ mV})\right)}{E_x(V_j + k \text{ mV}, V_j)} \times 1 \text{ mV}$$

- Here, $V_j + k_s \text{ mV}$ is a good approximation of ϕ_s .
- Parameters: V_{fb} is -1.08 V. C_{ox} is $2.88 \times 10^{-6} \text{ F/cm}^2$. (t_{ox} is 1.2 nm.) N_a is 10^{18} cm^{-3} .

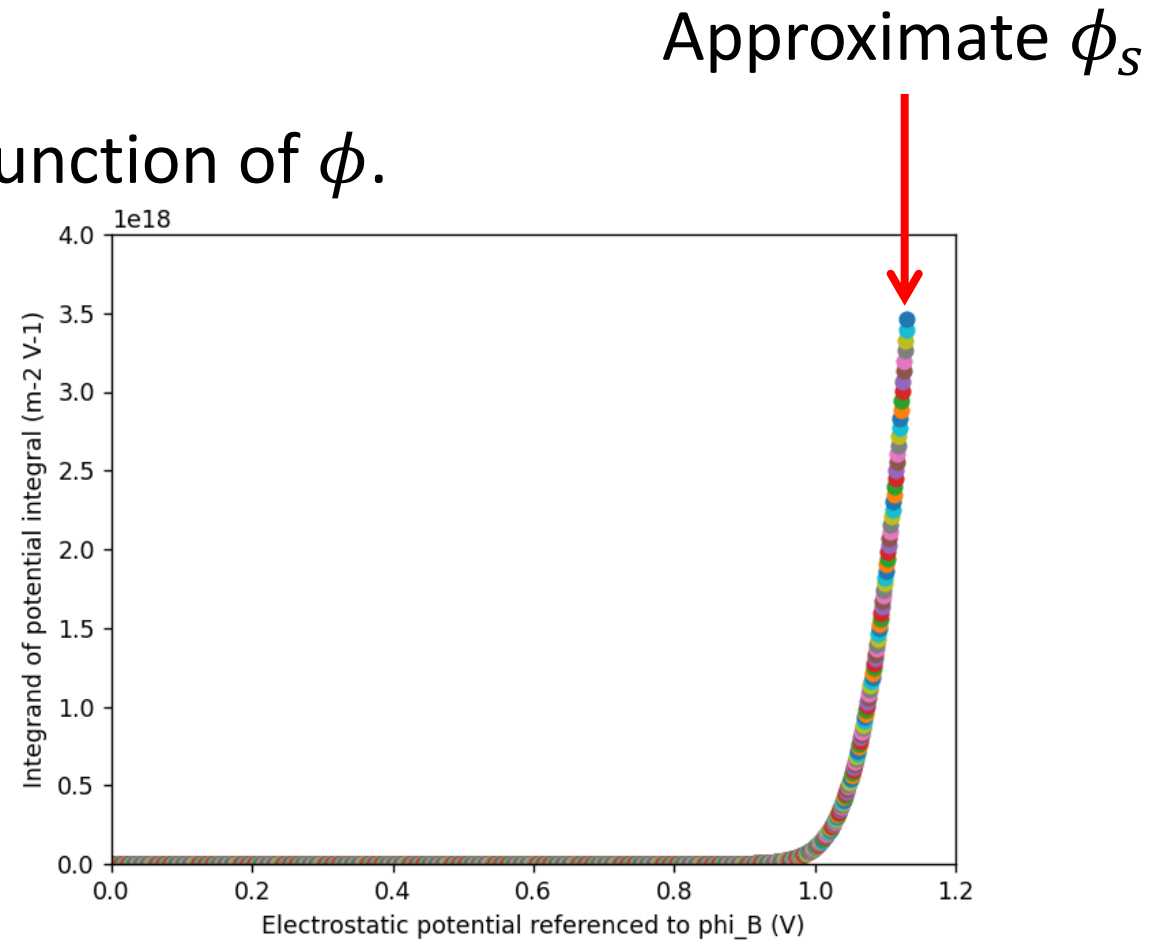
Write a code. (5)

- A specific example, when V_j is 0 V.

– Draw $\frac{(n_i^2/N_a) \exp\left(\frac{q}{k_B T}(\phi - V_j)\right)}{E_x(\phi, V_j)}$ as a function of ϕ .

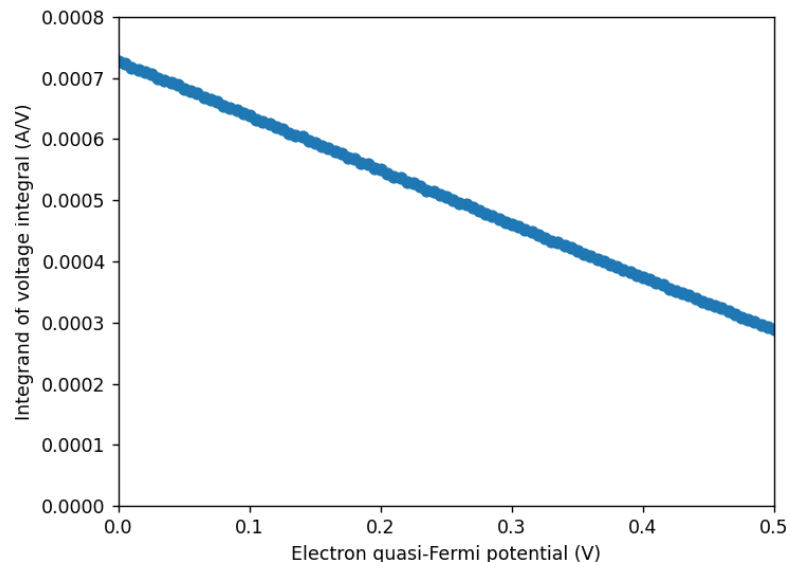
– Stopped when the MOS equation changes its sign. (Approximate ϕ_s)

– Integrated electron density is about $1.517 \times 10^{13} \text{ cm}^{-2}$.

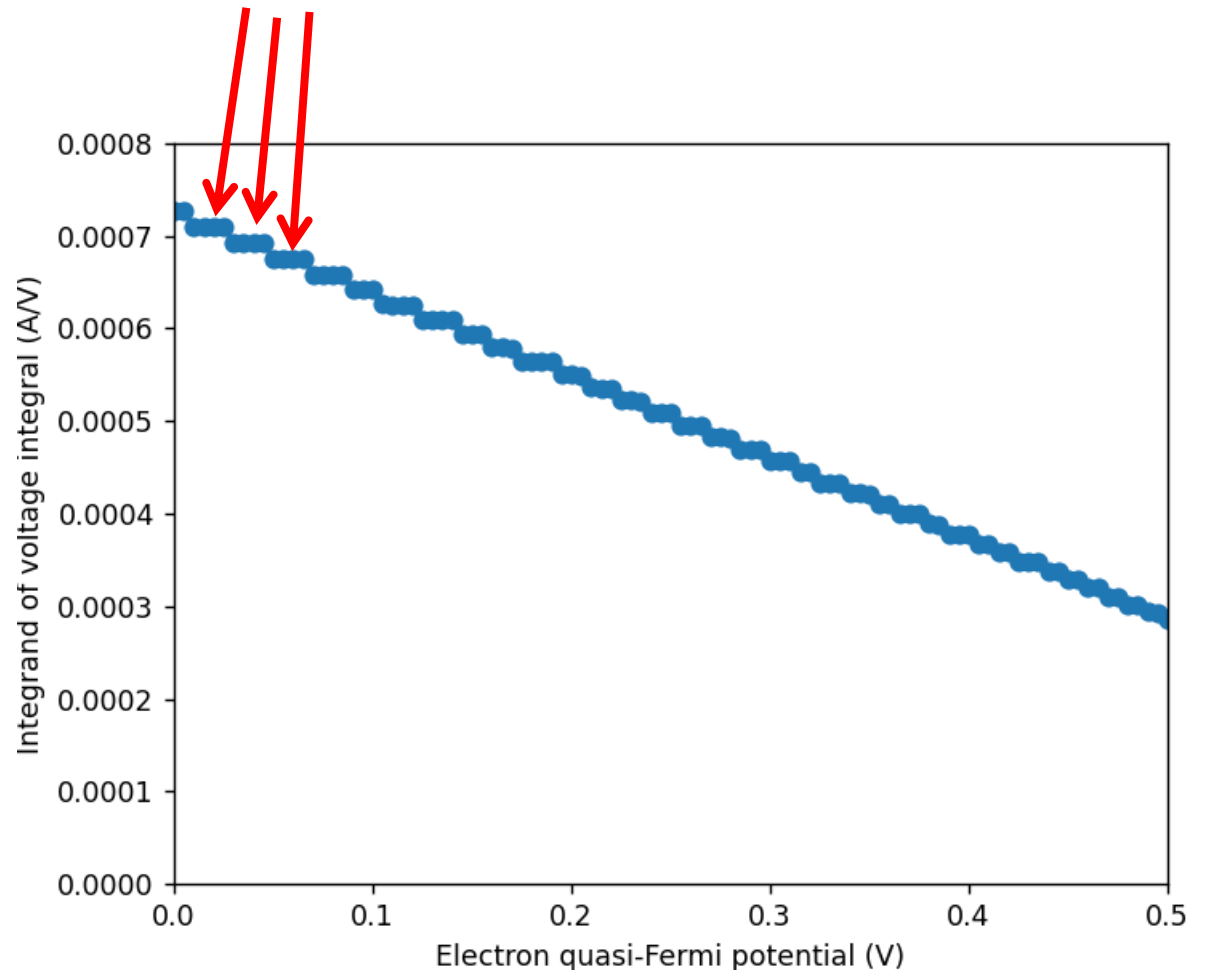


Write a code. (6)

- Integrand of the V -integral
 - By integrating it, we can find $I_d = 252.8 \mu\text{A}$.
 - Instead of 1 mV, we can try an even finer ϕ spacing.
 - With 0.2 mV, $I_d = 252.9 \mu\text{A}$.

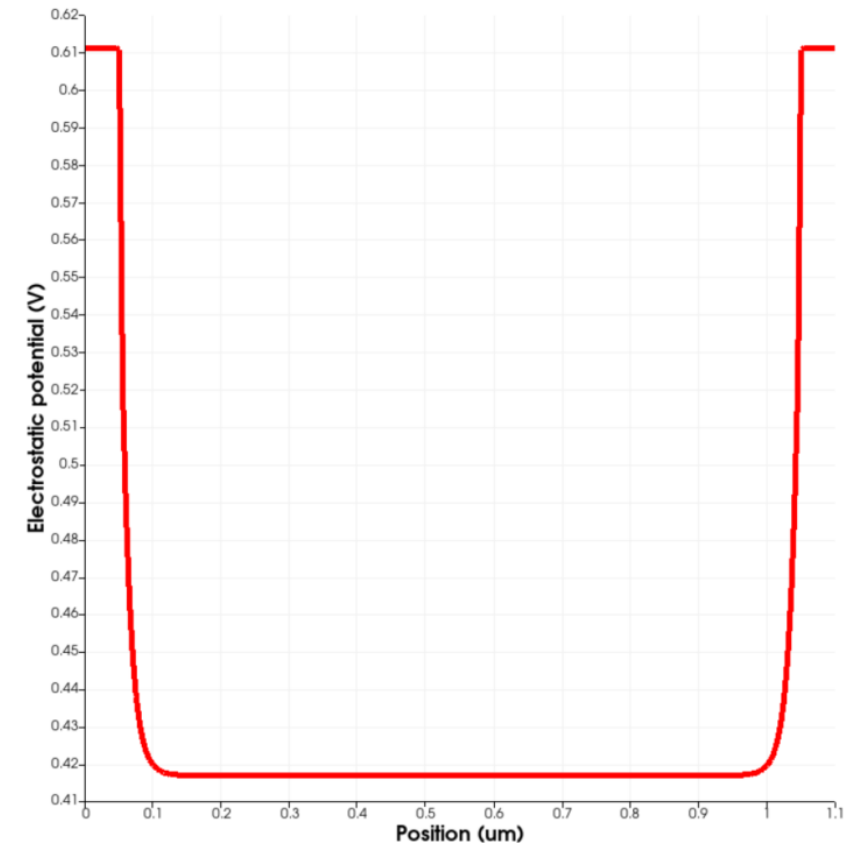
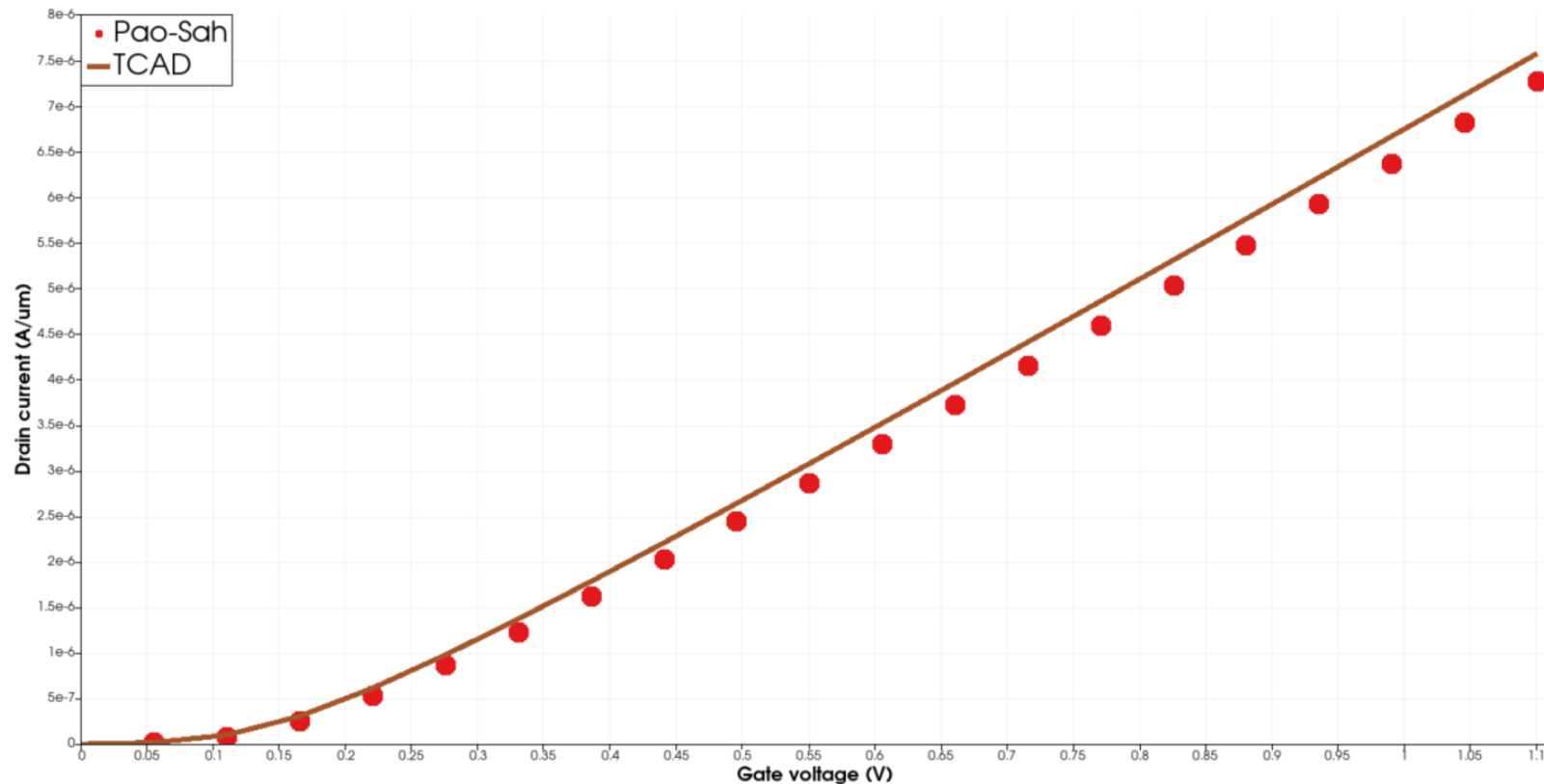


Step-wise???



Verify the result.

- TCAD simulation result (at $V_{ds} = 0.01$ V)
 - They are similar, but not perfectly matched. *Why?*



Charge-sheet model

- Simpler model with further approximations

- Consider the previous method to calculate Q_i :

$$Q_i = -q \int_{\delta}^{\phi_s} \frac{(n_i^2 / N_a) \exp\left(\frac{q}{k_B T} (\phi - V)\right)}{E_x(\phi, V)} d\phi$$

- A simpler way? Instead, Q_d is approximated as

$$Q_d = -q N_a W_d = -\sqrt{2\epsilon_{si} q N_a \phi_s} \quad \text{Taur, Eq. (3.15)}$$

- Then, Q_i can be approximated as

$$Q_i = Q_s - Q_d = -C_{ox}(V_{gs} - V_{fb} - \phi_s) + \sqrt{2\epsilon_{si} q N_a \phi_s} \quad \text{Taur, Eq. (3.16)}$$

(Of course, it is not exact.)

Thank you!